Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/791,186	LEE ET AL.	
Examiner	Art Unit	
Matthew G. Kayrish	2627	

SEARCHED				
Class	Subclass	Date	Examiner	
360	126	10/10/2006	мк	
360	128	10/10/2006	мк	
360	126	10/5/2006	MK	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT, FPRS) (See Attached Search History)	10/5/2006	МК	
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT, FPRS) (See Attached Search History)	10/10/2006	МК	
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT, FPRS) (See Attached Search History)	10/11/2006	МК	